

**Search Notes**

Application/Control No.

10/808,794

Examiner

Nam Huynh

Applicant(s)/Patent under  
Reexamination

LIOW ET AL.

Art Unit

2643

**SEARCHED**

Class	Subclass	Date	Examiner
455	556.1	12/21/2005	NTH
	556.2		
	164.2		
235	462.47	12/21/2005	NTH
	472.01		
	472.02		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See EAST search notes.	12/21/2005	NTH